¥न्त्र	Nation of Bafaranaa Cited				10/736 533 Re		pplicant(s)/Patent Under eexamination GAWA, KENICHI	
	Notice of References Cited				Examiner Amanda L. Lauritzen	Art Unit 3737	Page 1 of 1	
				U.S. P	PATENT DOCUMENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name			Classification	
*		LIC 2007/0211951	00 2007	Ogawa Kenichi			378/042	

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2007/0211851	09-2007	Ogawa, Kenichi	378/042
*	В	US-2007/0195932	08-2007	NAKAURA et al.	378/98.12
*	C	US-2007/0145978	06-2007	Kuhara, Shigehide	324/318
*	D	US-2006/0241390	10-2006	Kruger et al.	600/420
*	Ε	US-2006/0173276	08-2006	Van Den Brink et al.	600/410
*	F	US-2006/0140336	06-2006	Russinger et al.	378/004
*	G	US-2006/0109954	05-2006	Gohno, Makoto	378/098.12
*	Н	US-2006/0020198	01-2006	Riederer et al.	600/410
*	1	US-2005/0190983	09-2005	Odogba et al.	382/254
*	J	US-6,895,077	05-2005	Karellas et al.	378/98.3
*	К	US-6,764,217	07-2004	Yasuda et al.	378/205
*	L	US-5,386,450	01-1995	Ozawa, Masahiro	378/98.2
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р				-	
	α					
	R	•				
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages).							
	U								
	V								
	w								
	x								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.